# Product Preview

# **Power MOSFET**

# 60 V, 2.0 m $\Omega$ , 252 A, Single N–Channel, D<sup>2</sup>PAK7

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- Lowers Switching Noise/EMI
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

## **Typical Applications**

- Power Tools, Battery Operated Vacuums
- UAV/Drones, Material Handling
- BMS/Storage, Home Automation

# **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	60	V
Gate-to-Source Voltage	е		V <sub>GS</sub>	±20	V
Continuous Drain Current R <sub>θJC</sub> (Note 2)	Steady State	, I a = 25°(. I		252	Α
Power Dissipation $R_{\theta JC}$ (Note 2)	Olaic		P <sub>D</sub>	242	V
Continuous Drain Current $R_{\theta JA}$ (Notes 1, 2)	Steady State T <sub>A</sub> = 25°C		I <sub>D</sub>	31	Α
Power Dissipation $R_{\theta JA}$ (Notes 1, 2)			P <sub>D</sub>	3.8	W
Pulsed Drain Current	T <sub>A</sub> = 25	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	TBD	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	–55 to + 175	°C
Source Current (Body Diode)			Is	TBD	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L</sub> = TBD A <sub>pk</sub> , L = TBD mH)			E <sub>AS</sub>	TBD	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

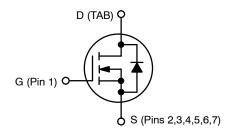
- 1. Surface-mounted on FR4 board using a 1 in2, 1 oz. Cu pad.
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.



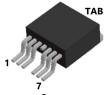
# ON Semiconductor®

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
60 V	2.0 m $\Omega$ @ 10 V	252 A
00 1	TBD mΩ @ 6 V	202 A



**N-CHANNEL MOSFET** 



D<sup>2</sup>PAK7 CASE 418AY





XXXX = Specific Device Code
A = Assembly Location

Y = Year WW = Work Week G = Pb-Free Package

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTBGS002N06C	D <sup>2</sup> PAK7 (Pb-Free)	800 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.

## THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{ hetaJC}$	0.62	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{ hetaJA}$	40	

# ELECTRICAL CHARACTERISTICS

Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>	I <sub>D</sub> = 225 μA, ref to 25°C			TBD		mV/°C
Zero Gate Voltage Drain Current	ero Gate Voltage Drain Current $I_{DSS}$ $V_{GS} = 0 \text{ V}, T_{J}$		T <sub>J</sub> = 25°C			10	μΑ
		$V_{DS} = 60 \text{ V}$	T <sub>J</sub> = 125°C			100	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS}$	= 20 V			100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	- 225 μA	2.0	3.0	4.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	I <sub>D</sub> = 225 μA, ref	to 25°C		TBD		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub>	= 45 A		TBD	2.0	
		V <sub>GS</sub> = 6 V, I <sub>D</sub>	= 23 A		TBD		mΩ
Forward Transconductance	9FS	$V_{DS} = 5 V, I_D$	= 45 A		TBD		S
Gate-Resistance	$R_{G}$	T <sub>A</sub> = 25°	С		1.0		Ω
CHARGES, CAPACITANCES & GATE RESIS	TANCE					•	
Input Capacitance	C <sub>ISS</sub>				4804		
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 \text{ V}, V_{DS} = 30 \text{ V}, f = 1 \text{ MHz}$			2854		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				26		
Total Gate Charge	Q <sub>G(TOT)</sub>				59		
Threshold Gate Charge	Q <sub>G(TH)</sub>				TBD		1
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS} = 10 \text{ V}, V_{DS} = 30 \text{ V}; I_D = 45 \text{ A}$			20		nC
Gate-to-Drain Charge	$Q_{GD}$				9.0		
Total Gate Charge	Q <sub>G(TOT)</sub>				TBD		1
SWITCHING CHARACTERISTICS (Note 4)	<u> </u>					1	
Turn-On Delay Time	t <sub>d(ON)</sub>				TBD		
Rise Time	t <sub>r</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 30 V, $I_{D}$ = 45 A, $R_{G}$ = 6 $\Omega$			TBD		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>				TBD		
Fall Time	t <sub>f</sub>				TBD		
DRAIN-SOURCE DIODE CHARACTERISTIC					•		•
Forward Diode Voltage	VGS = 0 V,	T <sub>J</sub> = 25°C		TBD	1.2		
		T <sub>J</sub> = 125°C		TBD		V	
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, dI}_{S}/dt = 100 \text{ A}/\mu\text{s,}$ $I_{S} = 23 \text{ A}$			TBD		
Charge Time	t <sub>a</sub>				TBD		ns
Discharge Time	t <sub>b</sub>				TBD		
Reverse Recovery Charge	Q <sub>RR</sub>				TBD		nC

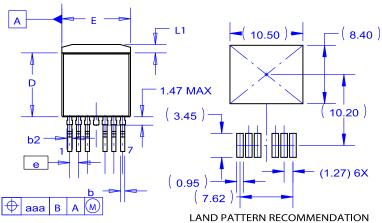
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

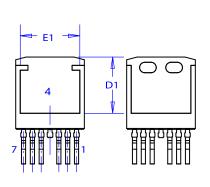
3. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .

4. Switching characteristics are independent of operating junction temperatures.

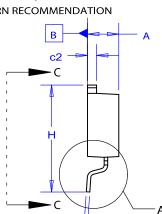
## **PACKAGE DIMENSIONS**

# D<sup>2</sup>PAK7 (TO-263 7 LD) CASE 418AY **ISSUE B**





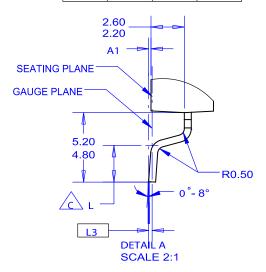
**OPTIONAL CONSTRUCTIONS VIEW C-C SCALE 2:1** 



#### NOTES:

- A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.
- D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-1994.
- E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS. F. LAND PATTERN RECOMMENDATION PER IPC. TO127P1524X465-8N.

DIM	MIL	LIMETER	S	
DIM	MIN NOM		MAX	
Α	4.30	4.50	4.70	
<b>A</b> 1	0.00	0.10	0.20	
b2	0.70	0.80	0.90	
b	0.51	0.60	0.70	
С	0.40	0.50	0.60	
c2	1.20	1.30	1.40	
D	9.00	9.20	9.40	
D1	6.70	6.80	6.95	
E	9.70	9.90	10.20	
E1	7.80	7.90	8.00	
е	~	1.27	~	
Н	15.10	15.40	15.70	
L	2.44	2.64	2.84	
L1	1.00	1.20	1.40	
L3	~	0.25	~	
aaa	~	~	0.25	



ON Semiconductor and in are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hol

## **PUBLICATION ORDERING INFORMATION**

#### LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800-282-9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative